

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10602355	SCHIFF, LEONARD N.
Examiner	Art Unit	
RICHARD CHAN	2618	

SEARCHED

Class	Subclass	Date	Examiner
455	12.1, 427, 428, 11.1, 13.1, 13.2,	5/17/11	RC

SEARCH NOTES

Search Notes	Date	Examiner
Consulted Raymond Dean (Primary) regarding prior art search	1/16/12	RC
Consulted Yuwen Pan for prior art and 112 1st paragraph rejection for claim 28	1/29/12	RC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	12.1, 427, 428, 11.1	8/24/12	RC

/RICHARD CHAN/
Examiner.Art Unit 2618